SHEET 1 OF 1

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION						ATTY. DOCKET NO. 57810-098		SERIAL NO.			
APPLICATION						APPLICANT Kenya UESUGI, et al.					
(PTO-1449)						FILING DATE GROUP March 30, 2004					
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"Sub-micron Device J', pp. 49-54, July 94,1007											
EXAMINER DATE CONSIDERED /Grant Sitta/ 04/30/2007											

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.